Application/Control No. Applicant(s)/Patent Under Reexamination 10/086,807 CHRISTIAN ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Julian Mercado 1745 **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY 12-2002 US-6,492,062 Wang et al. 429/223 Α US-5,759,718 06-1998 Yao et al. 429/223 В US-5,800,947 09-1998 429/223 Kohler et al. С US-D US-Ε US-F UŞ-G US-H US-1 US-J US-Κ US-L US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY 2001-202956 07-2001 Japan Kodama et al. Ν 10-284075 10-1998 Japan Maruta O Ρ Q R s T NON-PATENT DOCUMENTS Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ W

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.